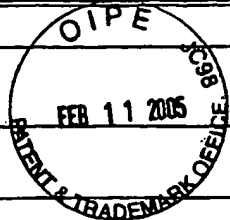


Sheet 1 of 1		INFORMATION DISCLOSURE STATEMENT					
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: February 11, 2005			ATTY DOCKET NO. 2003_1741A		SERIAL NO. 10/725,208		
			APPLICANT Masato YAMAMICHI et al.				
			FILING DATE December 2, 2003		GROUP 2131		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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	AD						
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	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AJ						
	AK						
	AL						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
OAL	AM	Howgrave-Graham et al., "The Impact of Decryption Failures on the Security of NTRU Encryption", Advances in Cryptology- Crypto 2003, 23 rd Annual International Cryptology Conference, Santa Barbara, CA, August 17-21, 2003 Proceedings, Lecture Notes in Computer Science, vol. 2729, Berlin, Springer, DE, August 17, 2003, pages 226-243					
OAL	AN	EESS: Consortium for Efficient Embedded Security: "Efficient Embedded Security Standards #1: Implementation Aspects of NTRUEncrypt and NTRUSign. Draft Version 2.0", EESS-Consortium for Efficient Embedded Security, 'Online! June 2003, pages 1-78					
OAL	AO	Institute of Electrical and Electronics Engineers, Inc.: "Standard Specification for Public-Key Cryptographic Techniques Based on Hard Problems over Lattices" IEEE Draft Standard P1363.1-D2, 'Online! May 18, 2001, pages 1-38					
OAL	AP	Menezes, Oorschot, Vanstone: "Handbook of Applied Cryptography", CRC Press Series on Discrete Mathematics and Its Applications, 1997, pages 506-508, 551, 552, 359-362, Boca Raton, FL, US					
EXAMINER		/Oscar A. Louie/ (01/08/2007)			DATE CONSIDERED 01/08/2007		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include cop. this form with next communication to applicant.

Sheet 1 of 1							
FORM PTO 1449 (modified)		ATTY DOCKET NO. 2003_1741A			SERIAL NO. 10/725,208		
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE							
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)							
Date Submitted to PTO: May 4, 2004					FILING DATE December 2, 2003		
GROUP							
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
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	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
OAL	AJ	2002-252611	9-6-02	Japan			abstract
OAL	AK	2000-516733	12-12-00	Japan			X
OAL	AL	98/08323	2-26-98	WO			X
	AM						
	AN						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
	AP						
	AQ						
EXAMINER				/Oscar A. Louie/ (01/08/2007)			
				DATE CONSIDERED 01/08/2007			

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